EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	482523	external test device or external testing device or external test equipment or automatic test equipment or (ATE) or external tester	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:25
L2	2686	(self test control device or "BIST" or built-in self test or self test circuit or in-circuit test or built-in test) same (integrated circuit or IC)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:29
L3	804	l1 and l2	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:29
L4	343	test result memory	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:32
L5	16	l3 and l4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:30
L6	0	output circuit same stored test results same external testing device	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:31
L7	1	output$4 and (stored test results same external testing device)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:31
L8	11048	evaluation device	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:32

L9	493511	l1 or l8	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:32
L10	5354	stor$3 and (test result$1 same (memory or internal memory))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:33
L11	808	l9 and l2	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:33
L12	161	l11 and l10	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:34
L13	18	l12 and l4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:34
L14	55	request$3 and (test result$1 same (xternal tester or external evaluation device or ATE))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:36
L15	4	l13 and l14	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:36
L16	26789	714/733 or 714/734 or 714/724 or 714/718 or 714/? or 365/200 or 365/201	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:37

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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L17	4	l15 and l16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 11:38
L19	18270	analyz$3 and (test result$1 same external terminal tester or ATE)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:00
L20	9	l19 and l13	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:00
L21	4	l20 and l14	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:22
L22	0	(Built-in self test AND BIST AND ATE AND external test device AND integrated circuit AND self test control device AND test result memory AND output device).clm.	US-PGPUB; USPAT; USOCR	ADJ	ON	2007/04/29 12:10
L23	5	"6771549"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:44
L24	2	"6940766"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:22
L25	2	(("6269030") or ("6665220")).PN.	US-PGPUB; USPAT	OR	OFF	2007/04/29 12:49

EAST Search History

L27	6	I20 and I16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/04/29 12:59
L28	9	(("4710927") or ("5355369") or ("5543730") or ("5568437") or ("5742613") or ("5805607") or ("6003142") or ("6327224") or ("6370661")).PN.	US-PGPUB; USPAT	OR	OFF	2007/04/29 13:00